Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/802,459	KOUNO ET AL.
Examiner	Art Unit
Scott L. Jarrett	3623

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH I (INCLUDING SEAR		()
	DATE	EXMR
EAST - JP, US, EP see attached search history	11/2/2005	SJ
Dialog see attached search history	11/2/2005	SJ
PLIS	11/2/05	B